

FIG. 1A

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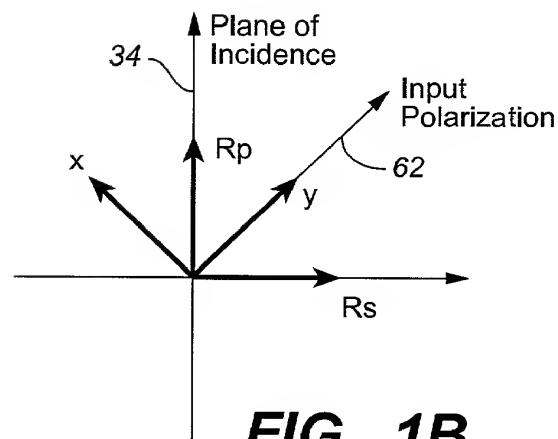


FIG._1B

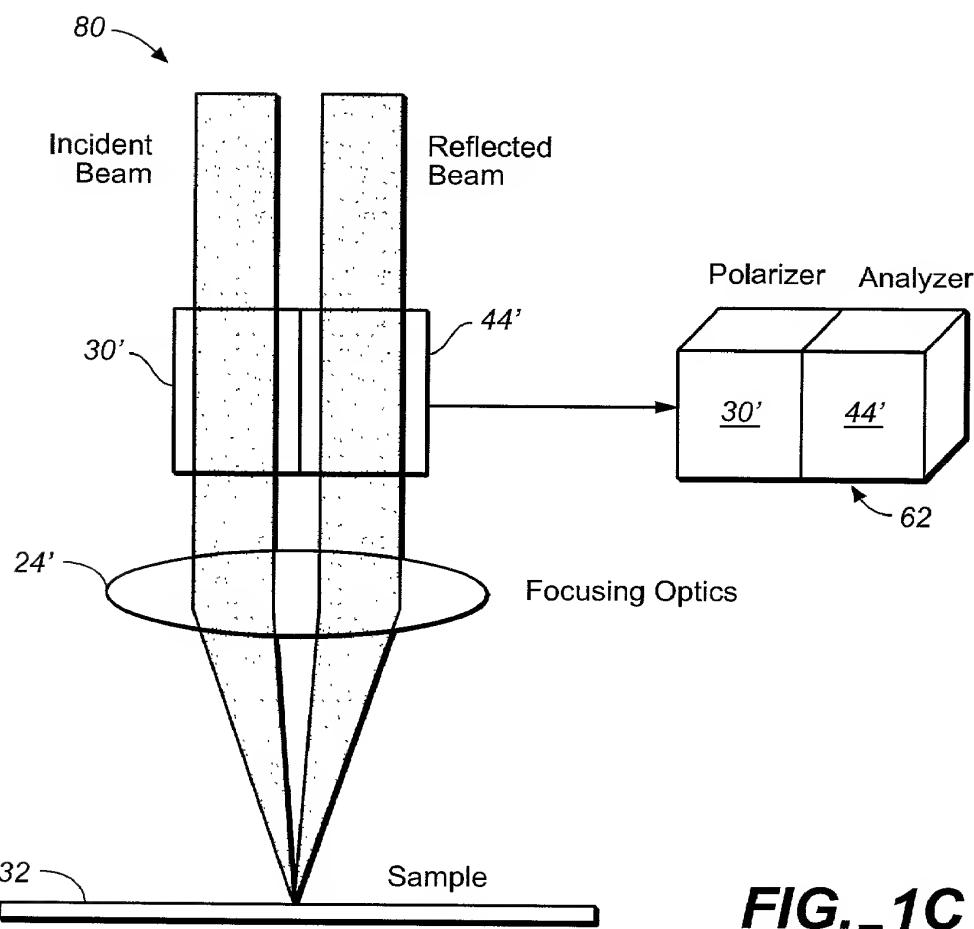


FIG._1C

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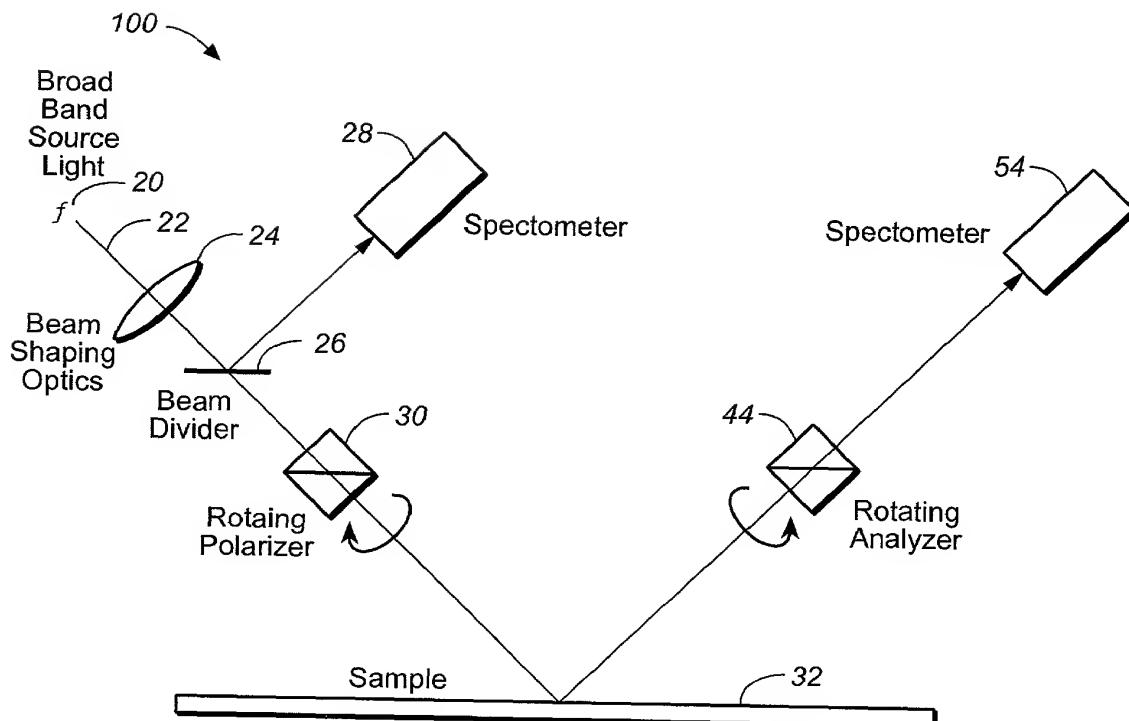


FIG._2

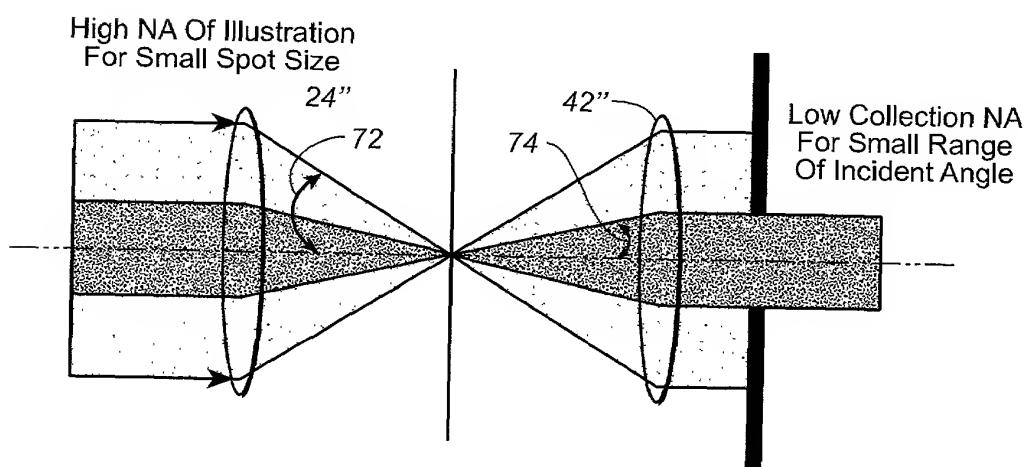
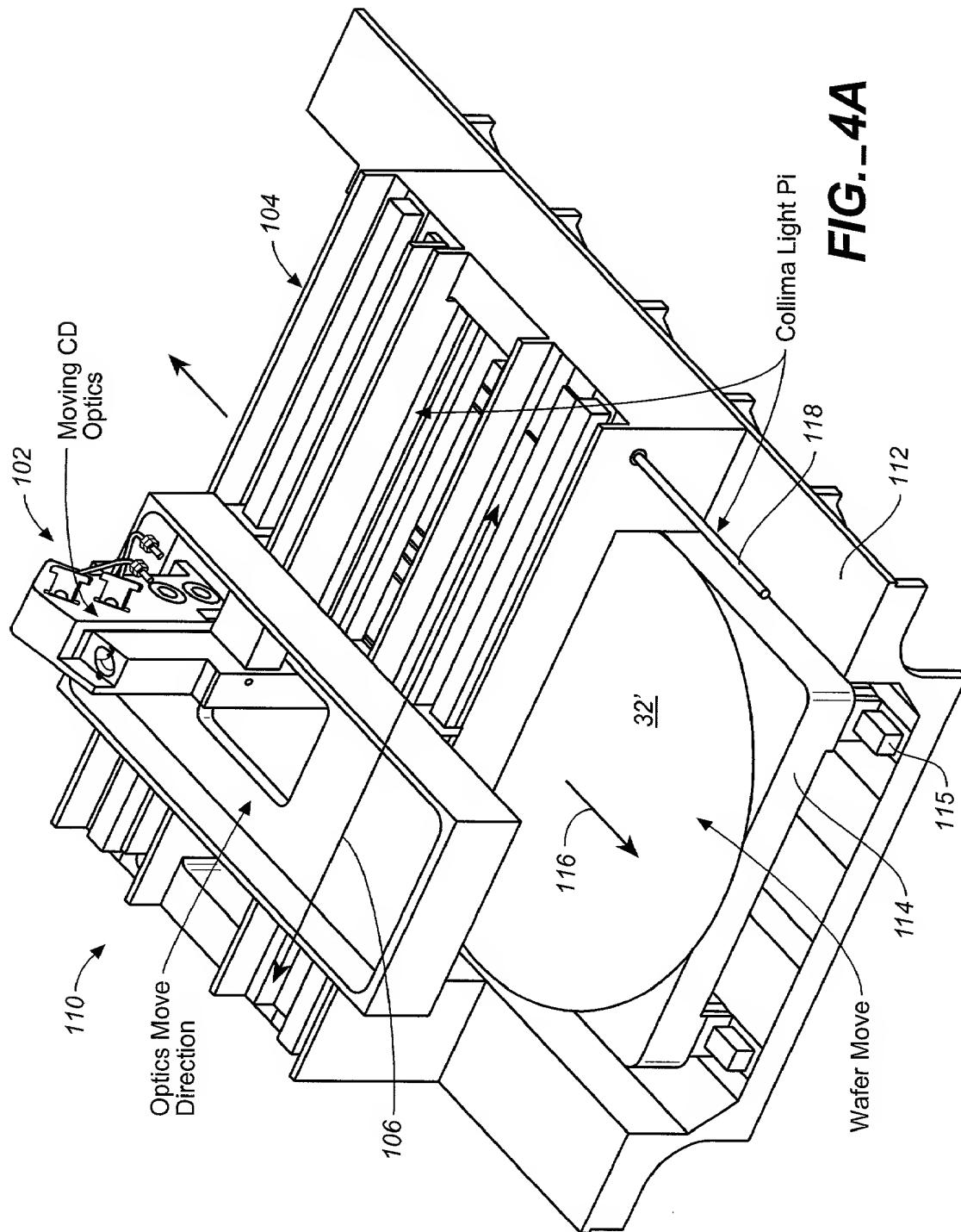


FIG._3

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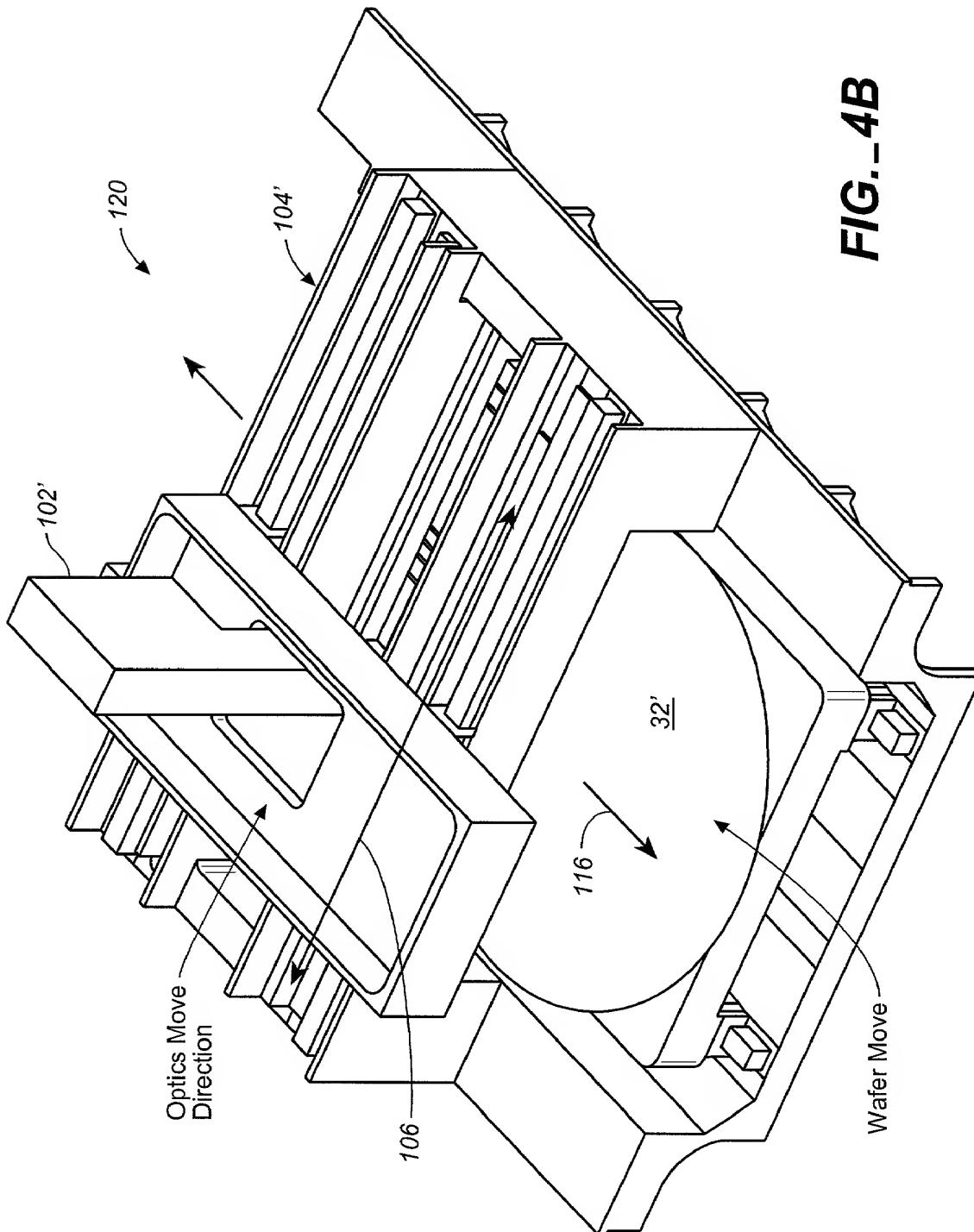


FIG. 4B

M-10696

U.S. Patent Application Serial No. 09/742,029

Inventors: Guoheng Zhao et al.

For: "Improved System for Measuring Periodic Structures"

Atty. Docket No.: M-10696 US

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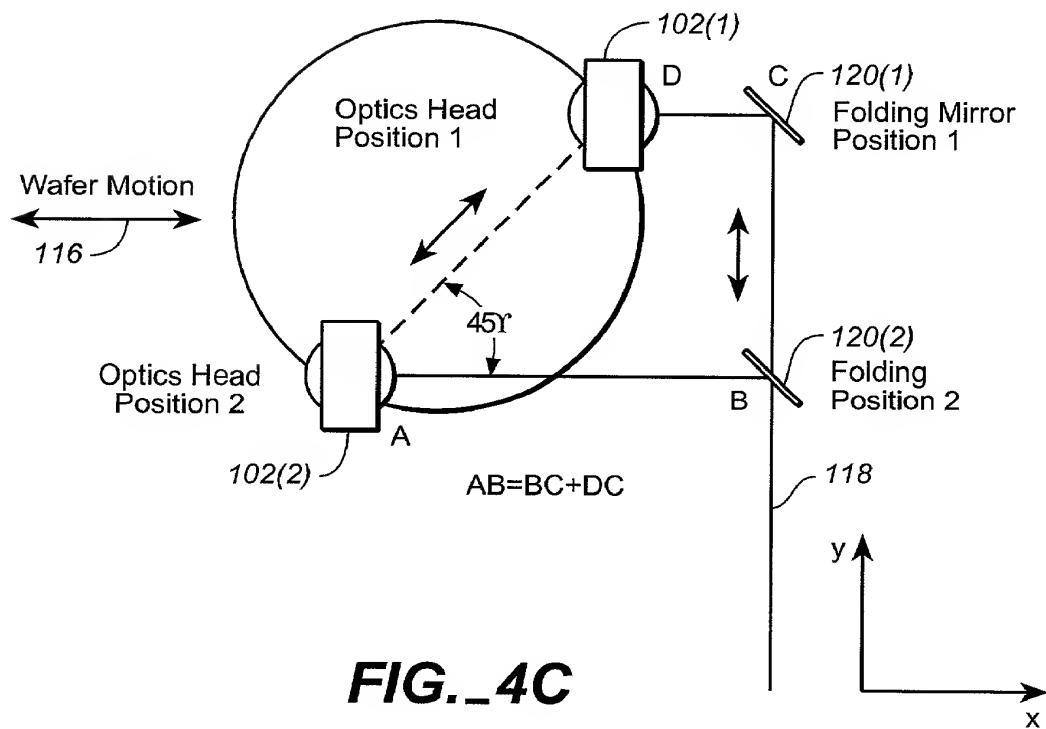


FIG._4C

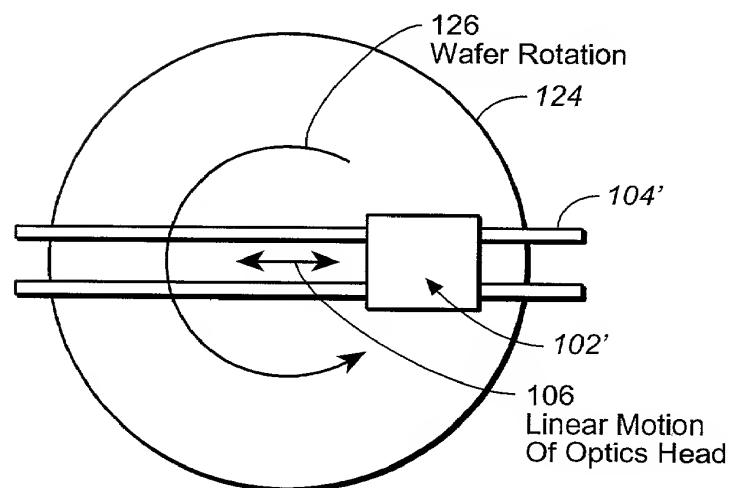


FIG._5

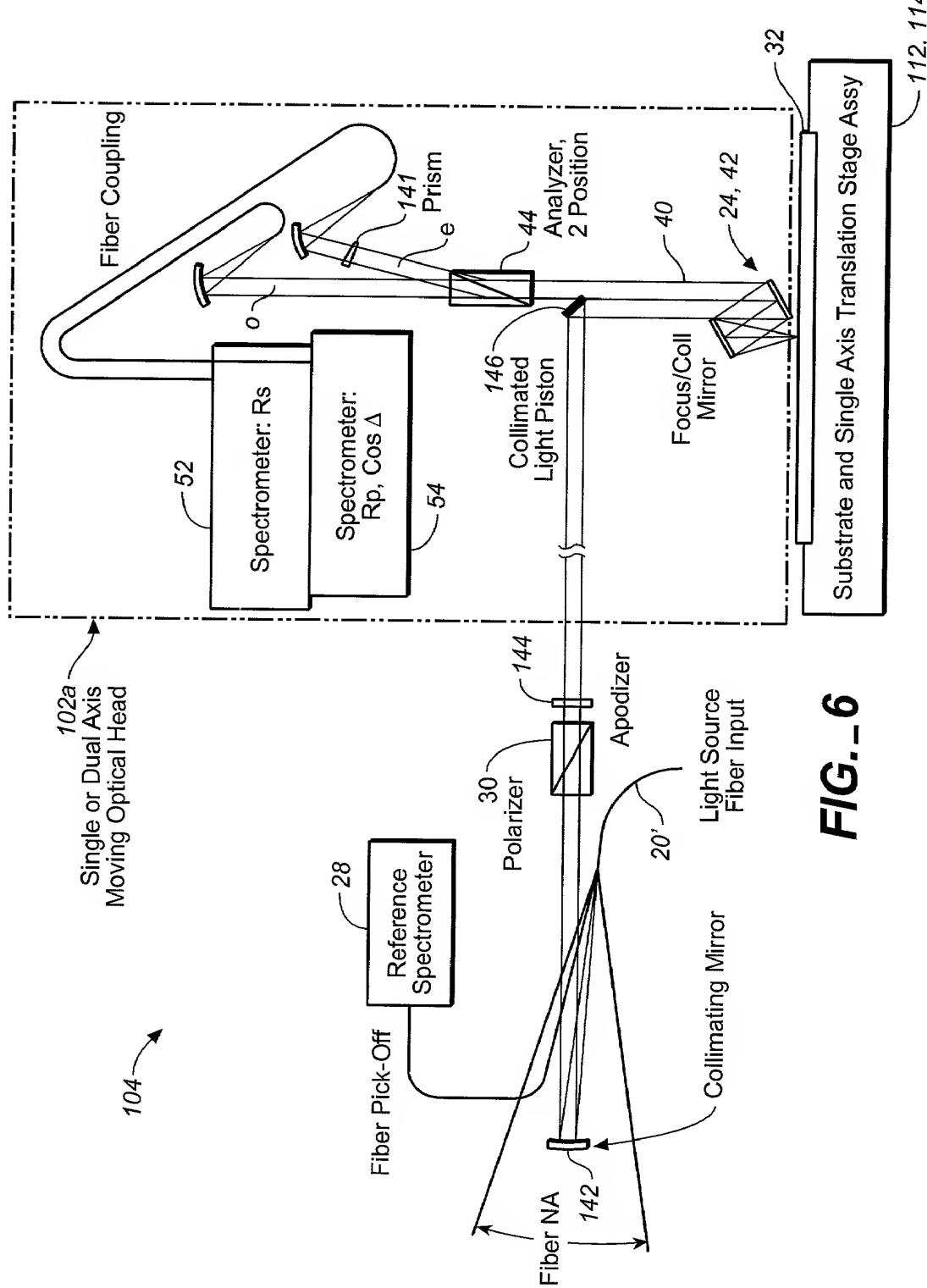


FIG. 6

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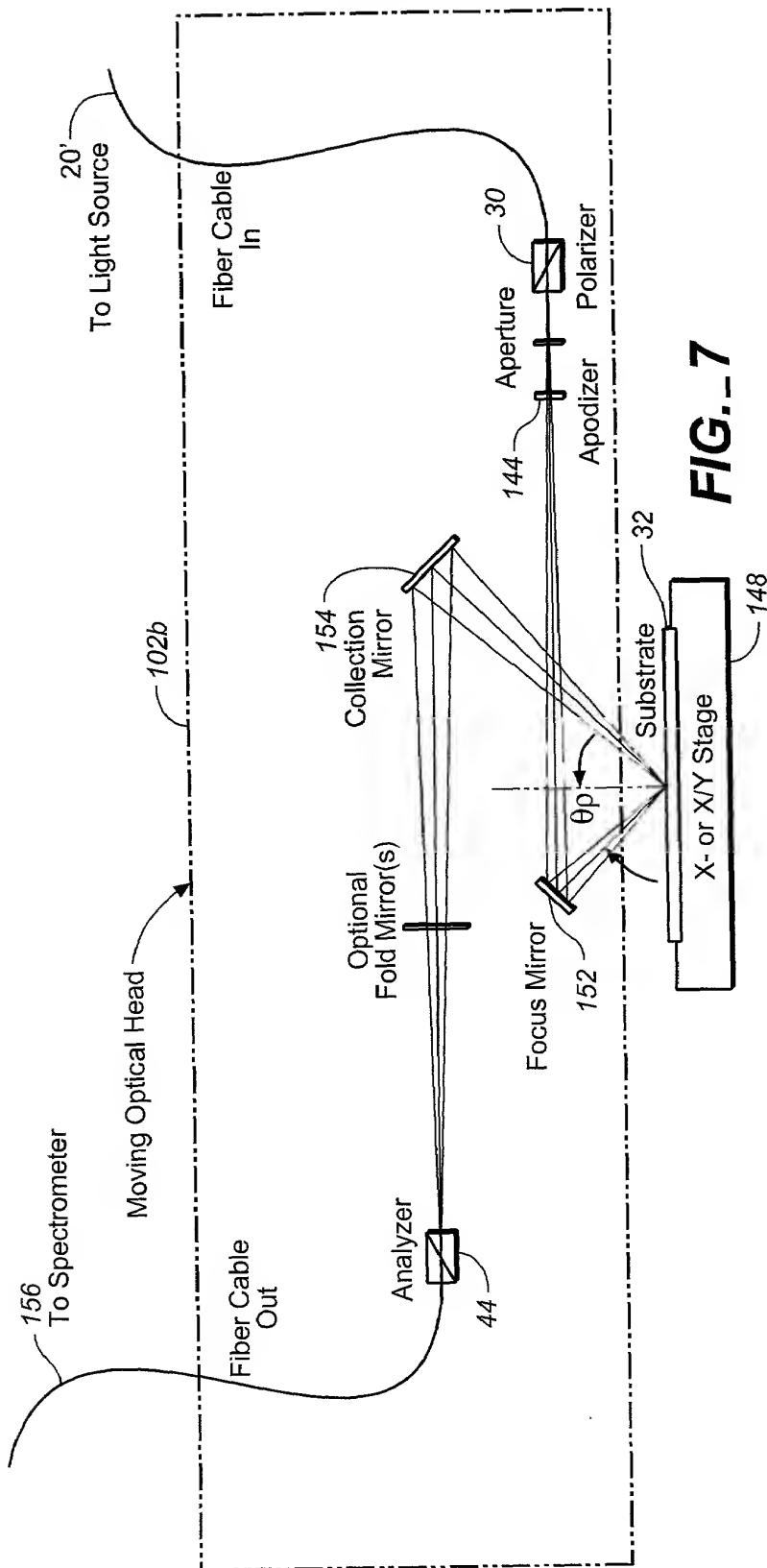


FIG.-7

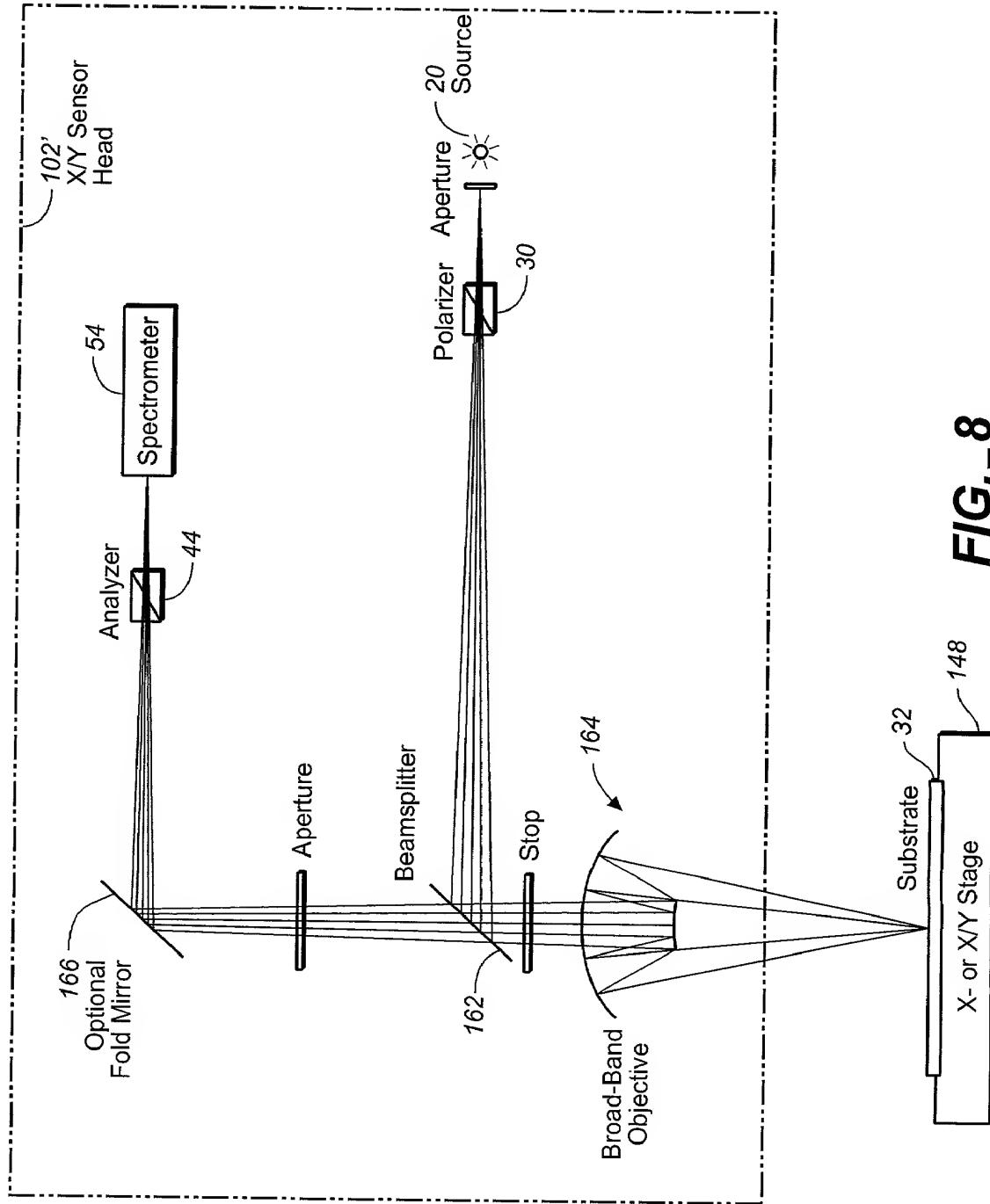


FIG. 8

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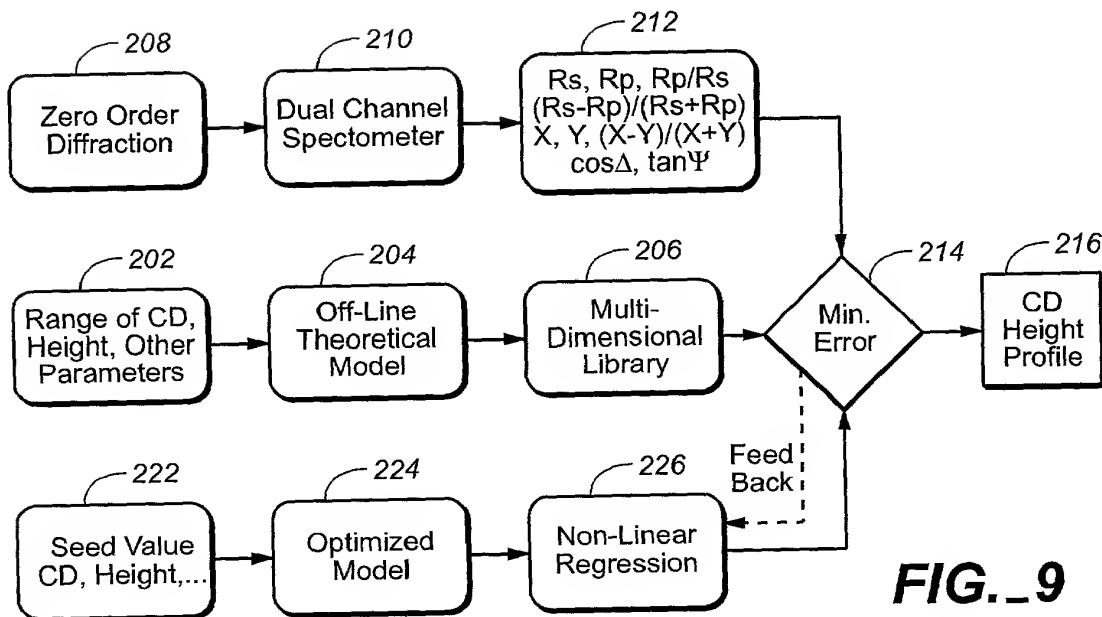


FIG._9

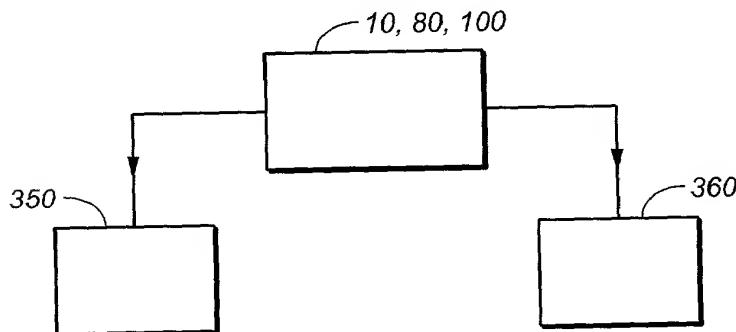


FIG._10

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